



LIST OF ART CITED BY APPLICANT
(PTO-1449)

ATTY. DOCKET NO. 05165.1240 SERIAL NO. 10/628,232

APPLICANT
Matthew J. WEIGEL

FILING DATE 7/29/03 GROUP

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
A <i>MW</i>	4,693,646	9/15/87	Mark J. Andrews	409	136	2/18/86
B <i>MW</i>	4,865,495	9/12/89	Buford R. Hinds	408	56	7/28/88
C						
D						
E						
F						
G						
H						
I						
J						
K						
L						
M						
N						
O						
P						
Q						
R						
S						
T						

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation
U						
V						
W						
X						
Y						
Z						
AA						
BB						
CC						
DD						
EE						
FF						
GG						

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

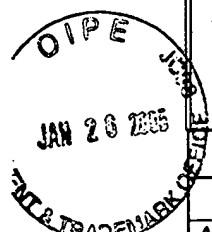
HH	
II	
JJ	
KK	
LL	
MM	
NN	

EXAMINER *Matthew J. Weigel* DATE CONSIDERED 12-09-05

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

Docket No.: 05165.1240

PATENT



LIST OF ART CITED BY APPLICANT
(PTO-1449)

ATTY. DOCKET NO. 05165.1240	SERIAL NO. 10/628,232
APPLICANT	
Matthew J. WEIGEL	

FILING DATE July 29, 2003	GROUP 3754
------------------------------	---------------

U. S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
A <i>MW</i>	6,105,595	8/22/2000	Jensen	137	15	3/7/1997
B <i>MW</i>	4,790,390	12/13/1988	Sweeny	173	17	1/25/1988
C						
D						
E						
F						
G						
H						
I						
J						
K						
L						
M						
N						
O						
P						
Q						
R						
S						
T						

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation
U <i>MW</i>	EP 758 568 A1	2/19/1997	Europe	823Q	1/00	
V <i>MW</i>	126 793 A1	5/28/1983	Germany	823Q	11/00	NO
W						
X						
Y						
Z						
AA						
BB						
CC						
DD						
EE						
FF						
GG						

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

HH	
II	
JJ	
KK	
LL	
MM	
NN	

EXAMINER	DATE CONSIDERED
<i>Matthew J. Weigel</i>	12-09-05

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.